Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/526,400	POYKKO ET AL.	
Examiner	Art Unit	
Nam Huynh	2617	

	SEAR	CHED	
Class	Subclass	Date	Examiner
See	Previous	12/6/2006	NTH
]			

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
-			
	<u> </u>		
			<u> </u>

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
A further evaluation of previously cited references was conducted	5/29/2007	NTH